

November 2010 UniFET TM

FDA24N50

N-Channel MOSFET 500V, 24A, 0.19Ω

Features

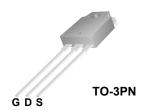
- $R_{DS(on)}$ = 0.16 Ω (Typ.)@ V_{GS} = 10V, I_D = 12A
- Low gate charge (Typ. 65nC)
- Low C_{rss} (Typ. 35pF)
- · Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · RoHS compliant

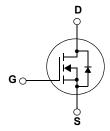


Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advance technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switching mode power supplies and active power factor correction.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol		Parameter		Ratings	Units
V_{DSS}	Drain to Source Voltage			500	V
V_{GSS}	Gate to Source Voltage			±30	V
	Drain Current	-Continuous (T _C = 25°C)		24	^
ID	Drain Current	-Continuous (T _C = 100°C)		14	_ A
I _{DM}	Drain Current	- Pulsed	(Note 1)	96	Α
E _{AS}	Single Pulsed Avalanche Energy	/	(Note 2)	1872	mJ
I _{AR}	Avalanche Current (N		(Note 1)	24	Α
E _{AR}	Repetitive Avalanche Energy (I		(Note 1)	27	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5	V/ns
D	Dower Discipation	(T _C = 25°C)		270	W
P_{D}	Power Dissipation	- Derate above 25°C		2.2	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	οС
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

Thermal Characteristics

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.46	
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ.	0.24	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	40	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDA24N50	FDA24N50	TO-3PN	-	-	30

Electrical Characteristics T_C = 25°C unless otherwise noted

Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$, $V_{GS} = 0 V$, $T_J = 25 ^{\circ} C$	500	-	-	V
$\Delta BV_{DSS} \over \Delta T_J$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.66	-	V/°C
1	Zero Gate Voltage Drain Current	V _{DS} = 500V, V _{GS} = 0V	-	-	1	
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 400V, T_C = 125^{\circ}C$	-	-	10	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 12A$	-	0.16	0.19	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 20V, I_D = 12A$ (Note 4)	ı	28	ı	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V - 25V V - 2V	-	3120	4150	pF
C _{oss}	Output Capacitance	V _{DS} = 25V, V _{GS} = 0V - f = 1MHz	-	460	615	pF
C _{rss}	Reverse Transfer Capacitance	- T- TWITE	-	35	52	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	65	85	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 400V, I_{D} = 24A$	-	18	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	$V_{GS} = 10V$ (Note 4, 5)	-	26	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			-	47	104	ns
t _r	Turn-On Rise Time	V _{DD} = 250V, I _D = 24A		-	108	226	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25\Omega$		-	164	338	ns
t _f	Turn-Off Fall Time		(Note 4, 5)	-	86	182	ns

Drain-Source Diode Characteristics

I_S	Maximum Continuous Drain to Source Diode Forward Current			-	-	24	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	-	96	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _{SD} = 24A		-	-	1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 24A		-	540	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	(Note 4)	-	8.1	-	μС

Notes:

- Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 6.5mH, I $_{AS}$ = 24A, V $_{DD}$ = 50V, R $_{G}$ = 25 Ω , Starting T $_{J}$ = 25°C
- 3. I_{SD} \leq 24A, di/dt \leq 200A/µs, V_{DD} \leq BV_DSS, Starting T_J = 25°C
- 4. Pulse Test: Pulse width $\leq 300 \mu s$, Duty Cycle $\leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

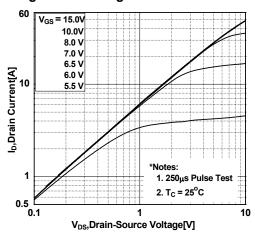


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

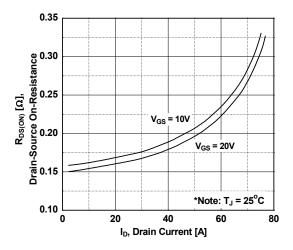


Figure 5. Capacitance Characteristics

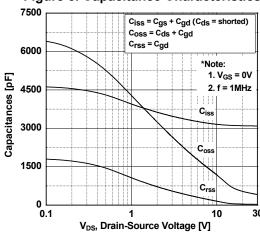


Figure 2. Transfer Characteristics

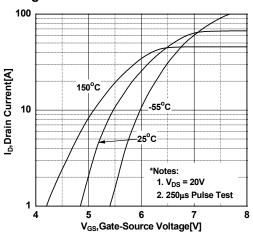


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

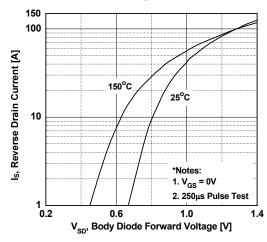
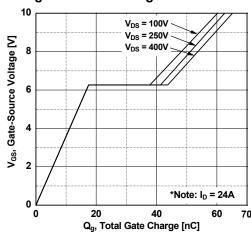


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

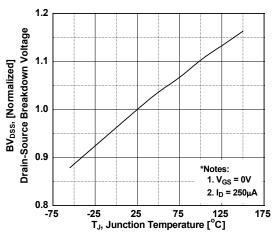


Figure 8. On-Resistance Variation vs. Temperature

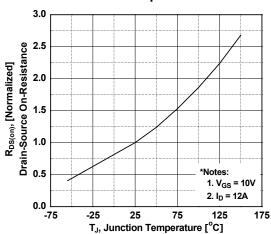


Figure 9. Maximum Safe Operating Area

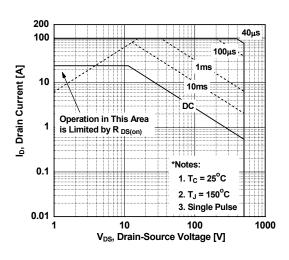


Figure 10. Maximum Drain Current vs. Case Temperature

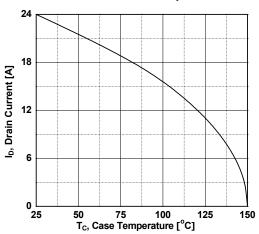
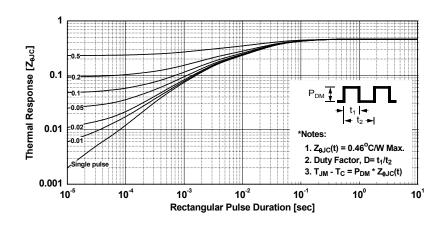
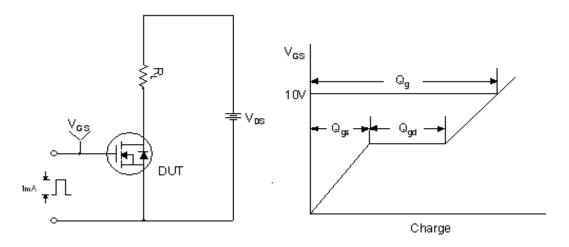


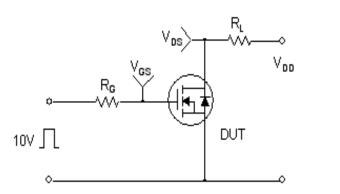
Figure 11. Transient Thermal Response Curve

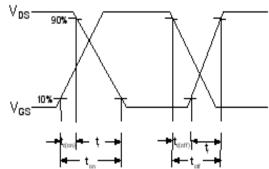


Gate Charge Test Circuit & Waveform

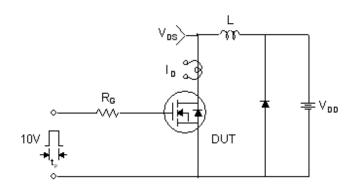


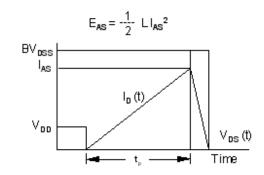
Resistive Switching Test Circuit & Waveforms



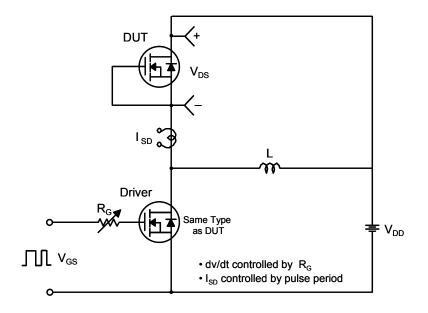


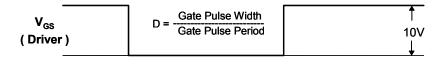
Unclamped Inductive Switching Test Circuit & Waveforms

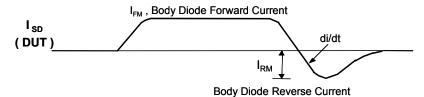




Peak Diode Recovery dv/dt Test Circuit & Waveforms





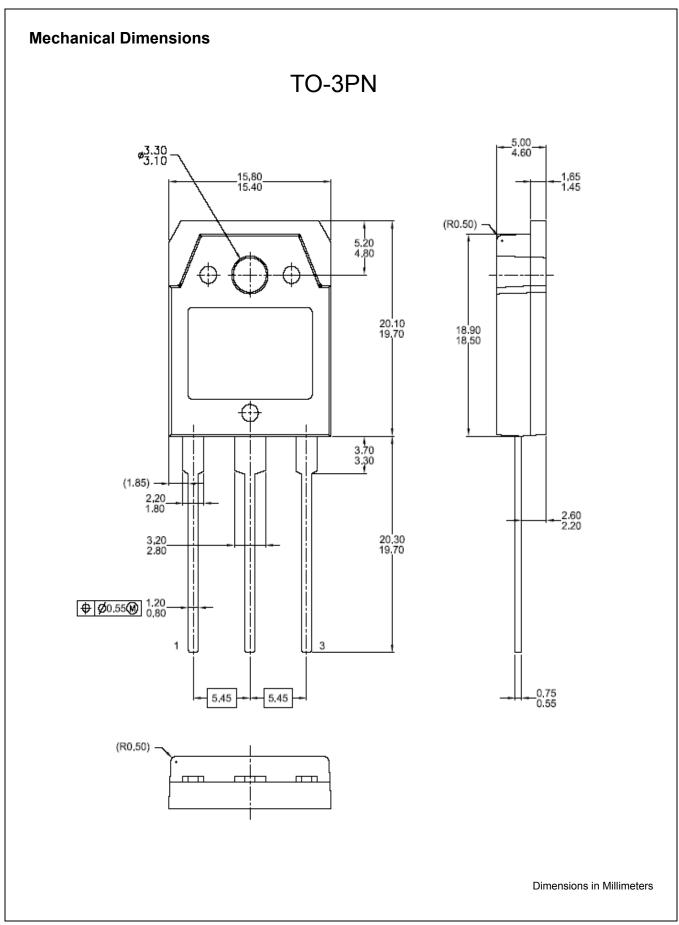


Body Diode Recovery dv/dt

V_{SD}

Body Diode

Forward Voltage Drop







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